

Search Notes

Application/Control No.

10/706,560

Examiner

Duc M. Nguyen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2685

SEARCHED

Class	Subclass	Date	Examiner
455	575.3 569.1 350		
	90.1 90.2		
	90.3 347		
	575.1		
379	433.01		
	433.02		
	433.13		
	432		
	420.01		
	420.02	3/3/06	DN ✓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	2/8/2006	DN
EAST	3/3/2006	DN